

Notice of References Cited	Application/Control No. 10/038,139	Applicant(s)/Patent Under Reexamination GAO ET AL.	
	Examiner Anil Khatri	Art Unit 2193	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,871,173	03-2005	Brauch, Rupert Julian Alexander	703/26
X	B	US-6,817,012	11-2004	Zammit et al.	717/136
X	C	US-6,760,904	07-2004	Jennion et al.	717/137
X	D	US-6,502,237	12-2002	Yates et al.	717/136
X	E	US-5,507,030	04-1996	Sites, Richard L.	717/136
X	F	US-6,006,245	12-1999	Thayer, John S.	708/404
X	G	US-5,664,134	09-1997	Gallup et al.	712/245
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Silberman et al, "An architectural framework for migration from CISC to higer performance platform"m ACM ICS, pp 198-215, 1992
	V	Sanz et al, "Computing multi colored polygonal mask in pipeline architectures and its application automated visual inspection", Comm. of the ACM, vol. 30, no. 4, pp 318-329, 1987
	W	Gschwind et al, "Binary traslation and architecture convergence issues for IBM system/390", ACM ICS, pp 336347, 2000
	X	Sites et al, "Binary translation", Comm. of the ACM, vol. 36, no. 3, pp 69-81, Feb. 1993

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.